

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10579033	DUNKEL ET AL.
Examiner	Art Unit	
Cho, Jennifer Y	1621	

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
STIC Search	12/5/07	STIC
East and Inventor Search	1/11/08	JC

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner